## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10829386	AN ET AL.
Examiner	Art Unit
Heyi, Henok G	2609

SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES		
Search Notes	Date	Examiner
Conducted search using EAST. I have also used google search. Some of the subclasses searched are 369/275.1 and 720/719 (text search only - please see search history printout).	06/19/2007	Henok Heyi
Updated search and consulted with examiner Brian Miller, Primary Examiners Tan Dinh and William Korzuch	03/03/2008	Henok Heyi
Search updated.	10/20/2008	Henok Heyi

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/HENOK G HEYI/ Examiner.Art Unit 2627	

U.S. Patent and Trademark Office Part of Paper No.: 20081018